Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/993,985	DUPERRAY, DAVID BENOIT DIDIER	
Examiner	Art Unit	
Jia W. Lu	2634	

SEARCHED					
Class	Subclass	Date	Examiner		
375	297	2/24/2005	JL		
375	295	2/18/2005	JL		
<u> </u>					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	297	2/24/2005	JL		
	,				

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2/24/2005	JL
INVENTORSHIP	2/18/2005	JL
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